



Certificate of Analysis

IARM 104B

AA 2024 / UNS A92024

Certified Reference Material

Certified Values listed in wt.% with associated uncertainties

B	0.0016 ± 0.0006	Be	0.00021 ± 0.00006	Cr	0.0088 ± 0.0008	Cu	4.63 ± 0.04
Fe	0.262 ± 0.005	Ga	0.011 ± 0.002	Mg	1.56 ± 0.01	Mn	0.645 ± 0.006
Ni	0.0053 ± 0.0005	Pb	0.014 ± 0.001	Si	0.150 ± 0.003	Sn	0.003 ± 0.001
Ti	0.056 ± 0.003	V	0.006 ± 0.001	Zn	0.065 ± 0.002	Zr	0.0010 ± 0.0005

Indicative Values listed in ppm

Ag (5)	Bi (<20)	Ca (<20)	Cd (<2)	Co (5)	Li (<50)	Na (5)
P (<50)	Sb (<200)	Sr (3)				

Description and Intended Use

This CRM may come in the form of a solid disc or chips. The intended use of this CRM may include, but is not limited to, the calibration of instruments and the validation of analytical methods.

Interpretation of Data

1. Certified values listed reflect analysis results submitted by qualified analytical laboratories using a combination of methods and instrumentation that emulate actual methods and instrumental techniques currently utilized in the analytical community, and are reported as wt% unless otherwise noted.
2. This material was tested using both the solid disks and chips prepared from individual sections of bar. The certified values are considered representative of the overall average composition of the material.
3. Any data reported and enclosed by a parentheses () is a "best estimate" and is not certified. This data could not be quantified sufficiently for certification. It was, however, reported by enough laboratories to be considered as potentially present in the matrix of the material being examined.
4. "Provisional Certificate of Analysis" reports values that support a fully certified reference material; it also indicates that values may be in a continued process of statistical evaluation and are subject to change.
5. Chips are not certified for Oxygen analysis.



The following data and accompanying statements represent all pertinent information reported in the ILAP as it applies to the chemical characterization of this material.

	Ag	B	Be	Bi	Ca	Cd	Co	Cr	Cu	Fe	Ga	Li	Mg	Mn	Na	Ni
1	0.0003	0.0008	0.0001	0.00007	0.0001	0.0002	0.0002	0.007	4.536	0.2508	0.0076	0.001	1.535	0.63	0.0001	0.004
2	0.0005	0.001	0.0002	0.0008	0.0013	0.00025	0.0003	0.007	4.569	0.254	0.0087	<0.0001	1.538	0.633	0.0004	0.0042
3	0.0008	0.0013	0.0002	0.0017	0.0017	<0.0001	0.0003	0.007	4.60	0.2547	0.0095	<0.0001	1.54	0.635	0.0006	0.0046
4	<0.0001	0.0019	0.0002	0.002	0.0019	<0.0001	0.001	0.0077	4.604	0.256	0.01	<0.0001	1.54	0.64	0.0008	0.0049
5	<0.0001	0.002	0.0002	<0.0001	<0.0003	<0.0001	<0.0005	0.008	4.605	0.258	0.0118	<0.0001	1.5447	0.64	<0.0001	0.0049
6		0.0023	0.0003	<0.0001	<0.005	<0.005	<0.0100	0.0083	4.6063	0.2592	0.0122	<0.005	1.554	0.6405	<0.005	0.005
7			0.0003	<0.001	<0.0050			0.0086	4.6078	0.26	0.0144		1.555	0.6407		0.0057
8				<0.01				0.009	4.61	0.261			1.5638	0.644		0.006
9								0.0093	4.611	0.2646			1.5661	0.647		0.006
10								0.0093	4.62	0.266			1.57	0.647		0.006
11								0.0093	4.625	0.27			1.5789	0.647		0.0061
12								0.01	4.696	0.275			1.60	0.651		0.0063
13								0.011	4.77	0.2775			1.606	0.6624		
14								0.011	4.80					0.668		
15																
Mean	0.0005	0.0016	0.00021	0.001	0.001	0.0002	0.0005	0.0088	4.63	0.262	0.011		1.56	0.645	0.0005	0.0053
STDV.	0.0003	0.0006	0.00007	0.0009	0.0008	0.00004	0.0004	0.001	0.07	0.008	0.002		0.02	0.01	0.0003	0.0008
Certified	(0.0005)	0.0016	0.00021	(<0.002)	(<0.002)	(0.0002)	(0.0005)	0.0088	4.63	0.262	0.011	(<0.005)	1.56	0.645	(0.0005)	0.0053
95% C.I.		0.0006	0.00006					0.0008	0.04	0.005	0.002		0.01	0.006		0.0005
Methods	O,IM,I	O,IM,I	O,IM,I	O,IM,I,G	O,IM,I,G	O,IM,I	O,IM,I	O,IM,I,G	O,IM,I,G	O,IM,I,G	O,IM,I	O,IM,I	O,I,G	O,I,G	O,IM,I	O,IM,I,G

	P	Pb	Sb	Si	Sn	Sr	Ti	V	Zn	Zr						
1	0.0003	0.0106	0.001	0.142	0.0001	0.0002	0.047	0.002	0.06	0.0004						
2	0.0003	0.012	0.0025	0.146	0.0003	0.0003	0.05	0.003	0.0605	0.0005						
3	0.001	0.0124	0.0163	0.1467	0.001	0.0003	0.0515	0.006	0.062	0.0008						
4	0.005	0.0127	<0.0001	0.1471	0.002	<0.0001	0.052	0.006	0.0636	0.001						
5		0.0128	<0.005	0.1475	0.0035	<0.0001	0.052	0.00615	0.0637	0.001						
6		0.013		0.149	0.004		0.054	0.0063	0.064	0.0014						
7		0.014		0.149	0.004		0.0557	0.0068	0.0645	0.002						
8		0.0143		0.15	0.0047		0.057	0.0072	0.065	<0.001						
9		0.0144		0.1505	0.0052		0.05825	0.0073	0.066	<0.005						
10		0.015		0.151			0.0587	0.0076	0.068	<0.005						
11		0.0161		0.153			0.0589	0.008	0.07							
12		0.0176		0.15585			0.0596		0.0733							
13				0.16			0.0597									
14							0.067									
15																
Mean	0.002	0.014	0.01	0.15	0.003	0.0003	0.056	0.006	0.065	0.001						
STDV.	0.002	0.002	0.008	0.005	0.002	0.00006	0.005	0.002	0.004	0.0005						
Certified	(<0.005)	0.014	(<0.02)	0.150	0.003	(0.0003)	0.056	0.006	0.065	0.0010						
95% C.I.		0.001		0.003	0.001		0.003	0.001	0.002	0.0005						
Methods	O,IM,I	O,IM,I,G	O,IM,I	O,IM,I,G	O,IM,I,G	O,IM,I	O,IM,I,G	O,IM,I,G	O,IM,I,G	O,IM,I,G						

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES

Participating Laboratories

LECO Corporation
Dirats Laboratories
NSL Analytical Services
SGS MSi
Anderson Laboratories, Inc.
IMR Test Labs

St. Joseph, MI
Westfield, MA
Cleveland, OH
Melrose Park, IL
Greendale, WI
Lansing, NY

Wagstaff, Inc.
Laboratory Testing, Inc.
Element - Newtown
Special Metals IncoTest
Exova - Gary
Laboratorio Prove Materiali S. Marco srl

Spokane Valley, WA
Hatfield, PA
Newtown, PA
Hereford, UK
Gary, IN
Schio, Italy

Traceability

Members of the "Inter-Laboratory Analysis Program" (ILAP) validate test methods and instrument performance utilizing SRMs, CRMs, and RMs produced by recognized Certifying Bodies. The specific SRMs, CRMs, and RMs applicable to the material covered by this certificate are:

ALCAN 1188-AB	ALCAN ALC-7075AB	ALCOA SS24U	ALCOA SS-7075GC	BCS 263/1	IARM 111A	NIST 3108	NIST 3152A	TRAMPS 2000
ALCAN 2014	ALCAN6463-AC	ALCOA SS380CE	ALCOA WC-1000X	BCS 300	NIST 1259	NIST 3109A	NIST 3161	WD 2024B
ALCAN 2024-AC	ALCOA 1005	ALCOA SS5052FG	ALU 234-01	BCS 300/1	NIST 3102A	NIST 3113	NIST 3169	
ALCAN A92024	ALCOA SS-2018H	ALCOA SS5086BH	ALU 524-02	BCS 300/14	NIST 3105A	NIST 3129A	NIST 856	
ALCAN ALC-2024AD	ALCOA SS2024-28	ALCOA SS-6061HA	BCS 181/2	IARM 104A	NIST 3106	NIST 3139A	NIST 85B	
ALCAN ALC-2024AY	ALCOA SS-2024DJ	ALCOA SS6063K	BCS 216/3	IARM 109A	NIST 3107	NIST 3151	NIST 859	

Homogeneity and Uncertainty

"Uncertainty" values, as reported adjacent to certified concentration values, are based on a 95% Confidence Interval. These estimated uncertainties include the combined effects of method imprecision, material inhomogeneity, and any bias between methods. Homogeneity data from experimental XRF results are reflected in both the overall statistics and certified data. Homogeneity samples are selected by a systematic sampling procedure. The number of samples may be determined by equation 1, where N_{prod} is the number of units produced and N_{min} is the number of samples used for homogeneity testing. These samples are arranged in a simple randomized design such that each sample is analyzed multiple times by XRF. Homogeneity is also determined within sample using an applied version of ASTM E826. A single factor ANOVA is used to calculate uncertainty due to inhomogeneity (U_{hom}). Uncertainty of the material is calculated by equation 2, where $H=U_{hom}$, S = Standard deviation, t = t-value at 95% CI, and n = number of observations.

$$1. N_{min} = \max(10, \sqrt[3]{N_{prod}}) \qquad 2. U_{CRM} = \frac{\sqrt{H^2 + S^2}}{\sqrt{n}} * t$$

The International Standards Organization (ISO) definitions, expressed in ISO Guide 30–1992 list the following:

Certifying Body: Any technically competent body (organization or firm, public or private) that issues a reference material certificate with the information detailed in ISO Guide 31. The only generally accepted certifying body in the United States for primary standards or Standard Reference Materials (SRM) is the U. S. Department of Commerce, National Institute of Standards & Technology (NIST), Gaithersburg, MD. All other certifying bodies in the United States produce Reference Materials (RM) or Certified Reference Materials (CRM).

Reference Material (RM): Material or substance, with one or more property values that are sufficiently homogeneous and well established, to be used for the calibration of an apparatus, the assessment of a measurement method, or for assigning values to materials.

Certified Reference Material (CRM): Reference material, accompanied by a certificate, with one or more property values certified by a procedure, which establishes its traceability to an accurate realization of the unit in which the property values are expressed, and for which each certified value is accompanied by an uncertainty at a stated level of confidence.

Inter-Laboratory Analysis Program (ILAP): ASTM Standard E691-87 applies to inter-laboratory studies to "Determine the Precision of a Single Test Method", but also outlines a well thought out and logical plan for conducting an inter laboratory program involving multiple analytical techniques. Therefore, the guidelines established in ASTM E691-87 were applied to all aspects of this inter laboratory program, including the protocols for planning, handling, analysis and treatment of resulting data.

Methods of Analysis: The "Inter Laboratory Analysis Program" analyzes a wide variety of materials, and as a result, no single analytical method would provide optimum analytical results. Therefore, a combination of ASTM Standard Methods for classical wet chemistry, ICP, AA, Optical Emission, X-Ray spectrometric, and other accepted methods were used to produce analytical data. Carbon, Sulfur, Nitrogen, and Oxygen results were supplied from combustion and OE instrument procedures.

Expiration of Certification: The certification of this IARM is valid indefinitely, within the uncertainty specified, provided the IARM is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the IARM is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.

Instructions for Use: The test surface is on the side opposite to the labeled surface, which includes the IARM number. The entire thickness of the unit is certified. However, the user is cautioned not to measure disks less than 2 mm thick when using X-ray fluorescence spectrometry. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing, as these processes may contaminate the surface. The minimum sample size for chips should be individually evaluated based on the analytical technique used; this would typically be greater than 0.1 grams. The material should be stored in a cool, dry location when not in use. **Chips are not to be used for Oxygen analysis.**

Selection of Materials: A "batch" or "series" is defined as a continuous length of bar produced from a single heat. The majority of IARM materials are in wrought condition; other methods of manufacture are utilized if necessary. ILAP samples are removed from equal sections from the total length of the bar. A portion of each section is converted to chips and a thin (pin) disk for analysis by classical wet chemistry, ICP, AA, and combustion procedures, and the balance remains as a thick disk for OES and X-Ray analysis.



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